

Application/Control No.		Applicant(s)/Patent under Reexamination	
	10/606,699	MEIRI ET AL.	
	Examiner	Art Unit	_
	Yaima Campos	2185	

	SEAR	CHED	
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EIC PLUS search	2/27/2006	YC		
PALM and EAST inventor name search	2/27/2006	YC		
Consulted 101 Hel Pannel - (William Grant)	2/27/2006	YC		
Text search within subclasses 11/113,118,135,141,154,161-162,165 and 707/10,204	2/27/2006	YC		